

10/528548

AOY-3989US

JC05 Rec'd PCT/PTO 21 MAR 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appn. No: To Be Assigned
Applicant: Eiichi Ito et al.
Filed: Herewith
Title: ELECTRON BEAM EXPOSURE METHOD AND ELECTRON BEAM
EXPOSURE SYSTEM
TC/A.U.:
Examiner:
Confirmation No.:
Docket No.: AOY-3989US

PRELIMINARY AMENDMENT

Mail Stop PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Prior to examination, please amend the above-identified application as follows:

- Amendments to the Title** begin on page 2 of this paper.
- Amendments to the Specification** begin on page 3 of this paper.
- Amendments to the Claims** are reflected in the listing of claims which begins on page _____ of this paper.
- Amendments to the Drawings** begin on page _____ of this paper and include an attached replacement sheet(s).
- Amendments to the Abstract** are on page _____ of this paper. A clean version of the Abstract is on page _____ of this paper.
- Remarks/Arguments** begin on page _____ of this paper.

Amendments to the Title:

Please replace the title with the following:

ELECTRON BEAM EXPOSURE METHOD AND ELECTRON BEAM EXPOSURE SYSTEM
ELECTRON BEAM EXPOSURE METHOD AND ELECTRON BEAM EXPOSURE APPARATUS